

Data Sheet



The Agilent E8257D is a fully synthesized signal generator with high output power, low phase noise, and optional ramp sweep capability.

Specifications apply over a 0 to 55 °C range, unless otherwise stated, and apply after a 45 minute warm-up time. Supplemental characteristics, denoted as typical, nominal, or measured, provide additional (non-warranted) information at 25 °C, which may be useful in the application of the product.

Definitions

Specifications (spec): Represents warranted performance for instruments with a current calibration.

Typical (typ): Represents characteristic performance which is non-warranted. Describes performance that will be met by a minimum of 80% of all products.

Nominal (nom): Represents characteristic performance which is non-warranted. Represents the value of a parameter that is most likely to occur; the expected mean or average.

Measured: Represents characteristic performance which is non-warranted. Represents the value of a parameter measured on an instrument during design stage.



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Specifications

Frequency



Range ¹							
Option 520	250 kHz to 20 GHz						
Option 532	250 kHz to 31.8 GHz						
Option 540	250 kHz to 40 GHz	250 kHz to 40 GHz					
Option 550	250 kHz to 50 GHz	250 kHz to 50 GHz					
Option 567	250 kHz to 67 GHz (ope	rational up to 70 GHz)					
Resolution							
CW	0.001 Hz						
All sweep modes	0.01 Hz ²						
CW switching speed ^{3, 4}	< 11 ms (typ)						
Phase offset	Adjustable in nominal 0.	1 ° increments					
Frequency bands							
Band	Frequency range	N ⁵					
1	250 kHz to 250 MHz	1/8					
2	> 250 to 500 MHz	1/16					
3	> 500 MHz to 1 GHz	1/8					
4	> 1 to 2 GHz	1/4					
5	> 2 to 3.2 GHz	1/2					
6	> 3.2 to 10 GHz	1					
7	> 10 to 20 GHz	2					
8	> 20 to 40 GHz	4					
9	> 40 GHz	8					
Accuracy	\pm aging rate \pm temperat	ure effects					
	± line voltage effects (no						
Internal timebase reference osc		, ,					
	Standard	Option UNR/UNX					
Aging rate	$< \pm 1 \times 10^{-7}$ /year or	$< \pm 3 \text{ x} 10^{-8}$ /year or					
5 5	$< \pm 4.5 \times 10^{-9}$ /day	$< \pm 2.5 \times 10^{-10}$ /day					
	after 45 days	after 30 days					
Temperature effects (typ)	$< \pm 5 \times 10^{-8}$ 0 to 55 °C	< ±4.5 x 10 ⁻⁹ 0 to 55 °C					
Line voltage effects (typ)	$< \pm 2 \times 10^{-9}$ for	$< \pm 2 \times 10^{-10}$ for					
3	+5% to -10% change	±10% change					
External reference frequency							
test & me	1, 2, 2.5, 5, 10 MHz	10 MHz only					
Lock range	±0.2 ppm	±1.0 ppm					
Reference output	FF	FF					
Frequency	10 MHz						
Amplitude	$>$ +4 dBm into 50 Ω load	d (tvp)					
External reference input		· \'/F/					
Amplitude	> –3 dBm						
Option UNR/UNX	$5 \text{ dBm} \pm 5 \text{ dB}^6$						
Input impedance	50 Ω (nom)						
	30 ()						

- 5. N is a factor used to help define certain specifications within the document.
- 6. To optimize phase noise use 5 dBm \pm 2 dB.

^{1.} Operational, but unspecified, down to 100 kHz.

^{2.} In ramp sweep mode (Option 007), resolution is limited with narrow spans and slow sweep speeds. Refer to ramp sweep specifications for more information.

^{3.} Time from GPIB trigger to frequency within 0.1 ppm of final frequency above 250 MHz or within 100 Hz below 250 MHz.

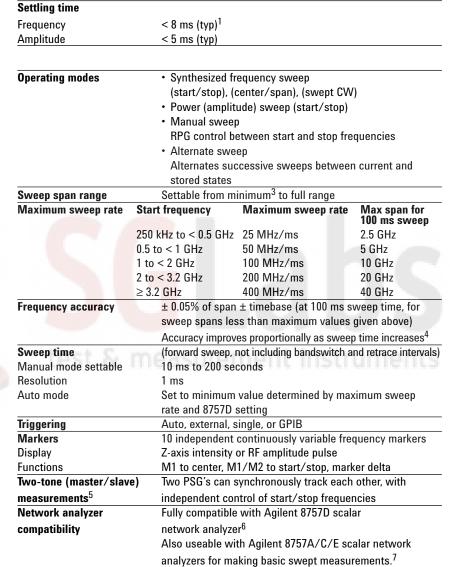
^{4.} Add 12 ms (typical) when switching from greater than 3.2 GHz to less than 3.2 GHz.

Step (digital) sweep

Operating modes	 Step sweep of frequency or amplitude or both (start to stop) 			
	• List sweep of frequency or amplitude or both (arbitrary list)			
Sweep range				
Frequency sweep	Within instrument frequency range			
Amplitude sweep	Within attenuator hold range (see "Output" section)			
Dwell time	1 ms to 60 s			
Number of points	2 to 65535 (step sweep)			
	2 to 1601 per table (list sweep)			
Triggering	Auto, external, single, or GPIB			
Settling time	-			
Frequency	< 8 ms (typ) ¹			
Amplitude	< 5 ms (typ)			

Ramp (analog) sweep

(Option 007)²



- 1. 19 ms (typ) when stepping from greater than 3.2 GHz to less than 3.2 GHz.
- 2. During ramp sweep operation, AM, FM, phase modulation, and pulse modulation are useable but performance is not guaranteed.
- 3. Minimum settable sweep span is proportional to carrier frequency and sweep time. Actual sweep span may be slightly different than desired setting for spans less than [0.00004% of carrier frequency or 140 Hz] x [sweep time in seconds]. Actual span will always be displayed correctly.
- Typical accuracy for sweep times > 100 ms can be calculated from the equation: [(0.005% of span)/(sweep time in seconds)] ± timebase. Accuracy is not specified for sweep times < 100 ms.
- 5. For master/slave operation use Agilent part #8120-8806 master/slave interface cable.
- 6. When measuring low-pass devices in AC mode, dynamic range may be reduced up to 10 dB below 3.2 GHz. An external highpass filter may be required to remove 27 kHz pulse source feed-through (11742A 45 MHz to 26.5 GHz blocking capacitor recommended).
- 7. GPIB system interface is not supported with 8757A/C/E, only with 8757D. As a result, some features of 8757A/C/E, such as frequency display, pass-through mode, and alternate sweep, do not function with PSG signal generators.

Output



Power ¹ (dBm) Frequency range	Standard	Option 1EA
		spec. (typ)
Option 520:	00 / 10	00 (. 10 (. 10)
250 kHz to 3.2 GHz	-20 to +13	-20 to +16 (+19)
250 kHz to 3.2 GHz with Option UNW	-20 to +11	-20 to $+11$ (+14)
250 kHz to 3.2 GHz with Option 1EH	$-20 \text{ to } +13^2$	-20 to $+13$ $(+16)^2$
250 kHz to 3.2 GHz with Options UNW and 1EH		-20 to $+10$ $(+13)^2$
> 3.2 Ghz to 5.2 GHz	-20 to +13	-20 to $+22 (+23)^4$
> 5.2 Ghz to 12 GHz	-20 to +13	-20 to $+23$ $(+24)^4$
> 12 Ghz to 20 GHz	–20 to +13	–20 to +21 (+23) ⁴
Options 532 and 540:		00
250 kHz to 3.2 GHz	-20 to +9	-20 to +15 (+18)
250 kHz to 3.2 GHz with Option UNW	-20 to +9	-20 to +10 (+13)
250 kHz to 3.2 GHz with Option 1EH	-20 to +9	-20 to $+12$ $(+15)^2$
250 kHz to 3.2 GHz with Options UNW and 1EH		-20 to +9 (+12) ²
> 3.2 to 17 GHz	-20 to +9	-20 to +19 (+21) ⁴
> 17 to 37 GHz	-20 to +9	-20 to +16 (+19) ⁴
> 37 to 40 GHz	–20 to +9	–20 to +14 (+17)
Options 550 and 567:		
250 kHz to 3.2 GHz	–20 to +5	–20 to +14 (+17)
250 kHz to 3.2 GHz with Option UNW	–20 to +5	-20 to +9 (+12)
250 kHz to 3.2 GHz with Option 1EH	–20 to +5	–20 to +11 (+14) ²
250 kHz to 3.2 GHz with Options UNW and 1EH	–20 to +5	–20 to +8 (+11) ²
> 3.2 to 10 GHz	–20 to +5	-20 to +14 (+21)
> 10 to 20 GHz	–20 to +5	-20 to +14 (+17)
> 20 to 30 GHz	–20 to +5	-20 to +11 (+17)
> 30 to 65 GHz	-20 to +5	-20 to +11 (+14)
> 65 to 67 GHz	–20 to +5	-20 to +10 (+14)
> 67 to 70 GHz	-20 to +5 (typ)	-20 to +8 (typ)
Option <mark>520 with st</mark> ep attenuator (Option 1E1):		
250 kHz to 3.2 GHz	–135 to +11	-135 to +15 (+18)
250 kHz to 3.2 GHz with Option UNW	-135 to +10	-135 to +10 (+13)
250 kHz to 3.2 GHz with Option 1EH	–135 to +1 ³	–135 to +12 (+15) ²
250 kHz to 3.2 GHz with Options UNW and 1EH	-135 to +9 ²	-135 to +9 (+12) ²
> 3.2 GHz to 10 GHz	–135 to +11	–135 to +21 (+22) ⁴
> 10 GHz to 20 GHz	–135 to +11	–135 to +19 (+20) ⁴
Options 532 and 540 with step attenuator (Opti	ion 1E1):	
250 kHz to 3.2 GHz	–135 to +7	–135 to +14 (+17)
250 kHz to 3.2 GHz with Option UNW	–135 to +7	-135 to +9 (+12)
250 kHz to 3.2 GHz with Option 1EH	–135 to +7	–135 to +11 (+14) ²
250 kHz to 3.2 GHz with Options UNW and 1EH	–135 to +7 ³	–135 to +8 (+11) ²
> 3.2 to 17 GHz	–135 to +7	–135 to +17 (+20) ⁴
> 17 to 37 GHz	–135 to +7	–135 to +14 (+17) ⁴
> 37 to 40 GHz	–135 to +7	-135 to +12 (+16)
Options 550 and 567 with step attenuator (Opti	ion 1E1):	
250 kHz to 3.2 GHz	-110 to +3	-110 to +13 (+16)
250 kHz to 3.2 GHz with Option UNW	–110 to +3	-110 to +8 (+11)
250 kHz to 3.2 GHz with Option 1EH	-110 to +3	-110 to $+10$ $(+13)^2$
250 kHz to 3.2 GHz with Options UNW and 1EH		–110 to +7 (+10) ²
> 3.2 to 10 GHz	–110 to +3	–110 to +13 (+20)
> 10 to 20 GHz	-110 to +3	-110 to +13 (+16)
> 20 to 30 GHz	-110 to +3	–110 to +9 (+16)
> 30 to 65 GHz	-110 to +3	-110 to +9 (+12)
> 65 to 67 GHz	-110 to +3	-110 to +8 (+12)
> 67 to 70 GHz	-110 to +3 (typ)	-110 to +6 (typ)
	- (-11)	1717

1. Maximum power specifications are warranted from 15 to 35 °C, and is typical from 0 to 15 °C. Maximum power over the 35 to 55 °C range typically degrades less than 2 dB.

2. With harmonic filters switched off. With filters on, maximum output power is reduced 3 dB for frequencies below 2 GHz.

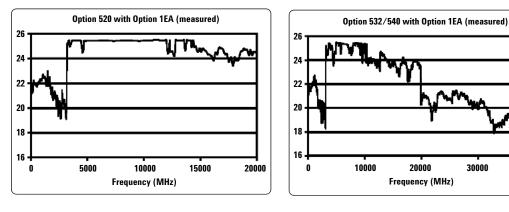
3. With harmonic filters switched off. With filters on, maximum output power is reduced 2 dB for frequencies below 2 GHz.

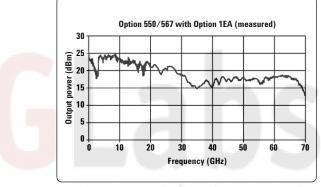
4. Specification applies to units with serial numbers ending with 45470000 or greater. For units with lower serial numbers, refer to the data sheet shipped with the unit or the version of this document dated December 16, 2004.

40000

Step attenuator¹ (Option 1E1) Options 520, 532, and 540 Options 550 and 567 Maximum available power (measured)

0 dB and 5 dB to 115 dB in 10 dB steps 0 dB to 90 dB in 10 dB steps





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Attenuator hold range

Minimum From –20 dBm to maximum specified output power with step attenuator in 0 dB position. Can be offset using Option 1E1 attenuator.

Amplitude switch	ing speed ²	•	0.	
ALC on or off		< 3 ms (typ)		
(without power se	arch)			
Level accuracy ³ (o	lB)			
Frequency	> +10 dBm	+10 to 0 dBm	0 to –10 dBm	–10 to –20 dBm
250 kHz to 2 GHz	±0.6	±0.6	±0.6	±1.4
> 2 GHz to 20 GHz	±0.8	±0.8	±0.8	±1.2
> 20 to 40 GHz	±1.0	±0.9	±0.9	±1.3
> 40 to 50 GHz		±1.3	±0.9	±1.2
> 50 to 67 GHz		±1.5	±1.0	±1.2 (typ)

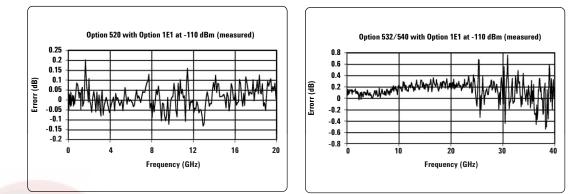
1. The step attenuator provides coarse power attenuation to achieve low power levels. Fine power level adjustment is provided by the ALC (Automatic Level Control) within the attenuator hold range.

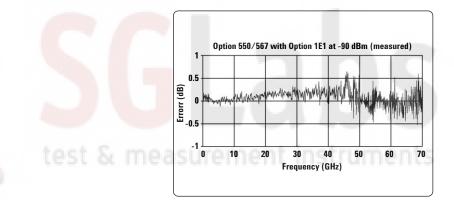
2. To within 0.1 dB of final amplitude within one attenuator range. Add 10 to 50 ms when using power search.

3. Specifications apply in CW and list/step sweep modes over the 15 to 35 °C temperature range. Degradation outside this range, for power levels > -10 dBm, is typically < 0.3 dB. In ramp sweep mode (with Option 007), specifications are typical. For instruments with Type-N connectors (Option 1ED), specifications are degraded typically 0.2 dB above 18 GHz. Specifications do not apply above the maximum specified power.</p>

Level accuracy with step attenuator (Option 1E1) ¹ (dB)								
Frequency	> +10 dBm	+10 to 0 dBm	0 to –10 dBm	–10 to –70 dBm	–70 to –90 dBm			
250 kHz to 2 GF	lz ±0.6	±0.6	±0.6	±0.7	±0.8			
> 2 to 20 GHz	±0.8	±0.8	±0.8	±0.9	±1.0			
> 20 to 40 GHz	z ±1.0	±0.9	±0.9	±1.0	±2.0			
> 40 to 50 GHz		±1.3	±0.9	±1.5	±2.5			
> 50 to 67 GHz	<u>z</u>	±1.5	±1.0	±1.5 (typ)	±2.5 (typ)			

Level accuracy (measured)





Resolution	0.01 dB
Temperature stability	0.01 dB/°C (typ) ²
User flatness correction	
Number of points	2 to 1601 points/table
Number of tables	Up to 10,000, memory limited
Path loss	Arbitrary, within attenuator range
Entry modes	Remote power meter ³ , remote bus, manual
	(user edit/view)

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Specifications apply in CW and list/step sweep modes over the 15 to 35 °C temperature range, with attenuator hold off (normal operating mode). Degradation outside this range, for ALC power levels > -10 dBm, is typically < 0.3 dB. In ramp sweep mode (with Option 007), specifications are typical. For instruments with type-N connectors (Option 1ED), specifications are degraded typically 0.2 dB above 18 GHz. Specifications do not apply above the maximum specified power.

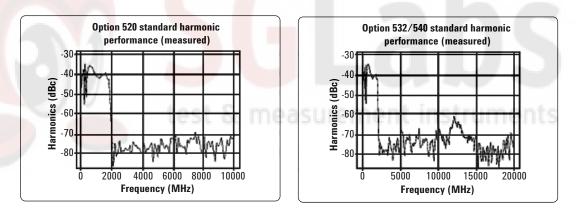
^{2.} Options 550 and 567: $0.03 dB/^{\circ}C$ (typ) above 2 GHz.

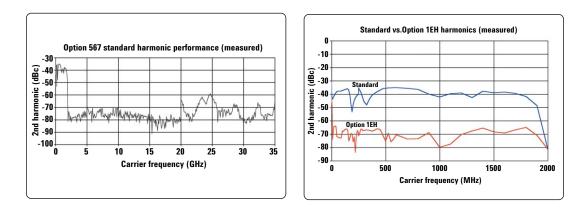
^{3.} Compatible with Agilent EPM Series (E4418B and E4419B) power meters.

Output impedance	50 Ω (nom)
SWR (internally leveled)	
250 kHz to 2 GHz	< 1.4:1 (typ)
> 2 GHz to 20 GHz	< 1.6:1 (typ)
> 20 GHz to 40 GHz	< 1.8:1 (typ)
> 40 GHz to 67 GHz	< 2.0:1 (typ)
Leveling modes	Internal leveling, external detector leveling,
	millimeter source module, ALC off
External detector leveling	
Range	–0.2 mV to –0.5 V (nom) (–36 dBm to
	+4 dBm using Agilent 33330D/E detector)
Bandwidth	Selectable 0.1 to 100 kHz (nom)
	(Note: not intended for pulsed operation)
Maximum reverse power	1/2 Watt, 0 V _{DC}

Spectral purity

Harmonics ¹	(dBc at +10 dBm or maximum specified
	output power, whichever is lower)
< 10 MHz	–28 dBc (typical below 1 MHz)
10 MHz to 2 GHz	–30 dBc ^{2,3}
10 MHz to 2 GHz (with Option 1EH filters on)	–55 dBc ⁴
> 2 GHz to 20 GHz	–55 dBc
> 20 GHz to 67 GHz (Option 532, 540, 550 & 567)	–50 dBc (typical)
Harmonics (measured)	





- 1. Specifications are typical for harmonics beyond specified frequency range (beyond 50 GHz for Option 567).
- 2. Specification applies to units with serial numbers ending with 45130000 or greater. For units with lower serial numbers, the specification is -28 dBc.
- 3. Typical below 250 MHz if Option 1EH is installed and the filters are off.
- 4. In ramp sweep mode (Option 007), harmonics are -30 dBc below 250 MHz.

Sub-harmonics ¹		(dBc at ±10 dB	3m or maximum s	nocified output		
Sup-liai liitiliitis				pecilieu outhut		
250 kHz to 10 GHz		None	power, whichever is lower) None			
> 10 GHz to 20 GHz		<60 dBc				
> 20 GHz		<50 dBc				
Non-harmonics ²		(dBc at +10 dE	3m or maximum s	pecified output		
			ever is lower, for o			
		•	Option UNX or U			
Frequency		Spec	Typical	17		
250 kHz to 250 MHz		-65	-72 for >	• 10 kHz offsets		
> 250 MHz to 1 GHz		-80				
> 1 to 2 GHz		-74	-82			
> 2 to 3.2 GHz		-68	-76			
> 3.2 to 10 GHz		-62	-70			
> 10 to 20 GHz		-56	-64			
> 20 to 40 GHz		-50	-58			
> 40 GHz		_44	-52			
SSB phase noise (CW	() ³	Offset from ca	. ,			
Frequency		20 kHz	20 kHz (1	typical)		
250 kHz to 250 MHz ⁴		-130	-134			
$> 250 \text{ to } 500 \text{ MHz}^4$		-134	-138			
> 500 MHz to 1 GHz ⁴ > 1 to 2 GHz ⁴		-130 -124	–134 –128			
> 2 to 3.2 GHz		-120	-128			
> 3.2 to 10 GHz		-110	-113			
> 10 to 20 GHz		-104	-108			
> 20 to 40 GHz		-98	-102			
> 40 to 67 GHz		-92	-96			
Option UNR: Enhance	d SSB phase n	oise (CW) ³				
		Offset from ca	rrier (dBc/Hz)			
Frequency	100 Hz	1 kHz	10 kHz	100 kHz		
	spec (typ)	spec (typ)	spec (typ)	spec (typ)		
250 kHz to 250 $\rm MHz^4$	-94 (-115)	-110 (-123)	-128 (-132)	-130 (-133)		
> 250 to 500 MHz ⁴	-100 (-110)	-124 (-130)	-132 (-136)	-136 (-141)		
> 500 MHz to 1 GHz ⁴	-94 (-104)	-118 (-126)	-130 (-135)	-130 (-135)		
> 1 to 2 GHz ⁴	-88 (-98)	-112 (-120)	-124 (-129)	–124 (–129)		
> 2 to 3.2 GHz	-84 (-94)	-108 (-116)	-120 (-125)	-120 (-125)		
> 3.2 to 10 GHz	-74 (-84)	-98 (-106)	-110 (-115)	-110 (-115)		
> 10 to 20 GHz	, ,		-104 (-107)			
	-68 (-78)	-92 (-100)	. ,	-104 (-109)		
> 20 to 40 GHz	-62 (-72)	-86 (-94)	-98 (-101)	-98 (-103)		
> 40 to 67 GHz	-56 (-66)	-80 (-88)	-92 (-95)	-92 (-97)		



1. Sub-harmonics are defined as Carrier Freq / N). Specifications are typical for sub-harmonics beyond specified frequency range (beyond 50 GHz for Option 567).

2. Specifications are typical for spurs beyond specified frequency range (beyond 50 GHz for Option 567). Specifications apply for CW mode, without modulation. In ramp sweep mode (Option 007), performance is typical for offsets > 1 MHz.

- 3. Phase noise specifications are warranted from 15 to 35 °C.
- 4. Measurement at +10 dBm or maximum specified output power, whichever is less.

Option UNX: Absolute SS	B phase noise (dB	c/Hz) (CW) ¹				
			Offset from carrier	r		
Frequency	1 Hz	10 Hz	100 Hz	1 kHz	10 kHz	100 kHz
250 kHz to 250 MHz ²	Spec (typ) -58 (-66)	Spec (typ) 87 (94)	Spec (typ) -104 (-120)	Spec (typ) -121 (-128)	Spec (typ) -128 (-132)	Spec (typ) –130 (–133)
> 250 to 500 MHz ²	-61 (-72)	-88 (-98)	-108 (-118)	-126 (-132)	-132 (-136)	-136 (-141)
> 500 MHz to 1 GHz ²	-57 (-65)	-84 (-93)	—101 (—111)	-121 (-130)	-130 (-134)	—130 (—135)
> 1 to 2 GHz ²	51 (58)	-79 (-86)	-96 (-106)	-115 (-124)	-124 (-129)	—124 (—129)
> 2 to 3.2 GHz	-46 (-54)	-74 (-82)	-92 (-102)	-111 (-120)	-120 (-124)	-120 (-124)
> 3.2 to 10 GHz	-37 (-44)	-65 (-72)	-81 (-92)	-101 (-109)	-110 (-114)	—110 (—115)
> 10 to 20 GHz	-31 (-38)	-59 (-66)	-75 (-87)	-95 (-106)	-104 (-107)	-104 (-109)
> 20 to 40 GHz	-25 (-32)	-53 (-60)	-69 (-79)	-89 (-99)	-98 (-101)	-98 (-103)
> 40 to 67 GHz	-20 (-26)	-47 (-56)	-64 (-73)	-84 (-90)	-92 (-95)	-92 (-97)

Option UNX: Residual SSB phase noise (dBc/Hz) (CW) 1

			Offset from carrie	r			
Frequency	1 Hz Snoo (twn)	10 Hz Snoo (turn)	100 Hz	1 kHz	10 kHz	100 kHz	
	Spec (typ)	Spec (typ)	Spec (typ)	Spec (typ)	Spec (typ)	Spec (typ)	
250 kHz to 250 MHz ²	(-94)	-100 (-107)	-110 (-118)	-120 (-126)	-128 (-132)	-130 (-133)	
> 250 to 500 MHz ²	(-101)	-105 (-112)	-115 (-122)	-124 (-131)	-132 (-136)	-136 (-141)	
> 500 MHz to 1 GHz ²	(—94)	-100 (-107)	-110 (-118)	-120 (-126)	-130 (-134)	-130 (-134)	
> 1 to 2 GHz ²	(—89)	-96 (-101)	_104 (<mark>_11</mark> 2)	-114 (-120)	-124 (-129)	-124 (-129)	
> 2 to 3.2 GHz	(85)	-92 (-97)	-100 (-108)	<u> </u>	-120 (-124)	-120 (-124)	
> 3.2 to 10 GHz	(74)	(87)	(–98)	(-106)	(-114)	(–115)	_

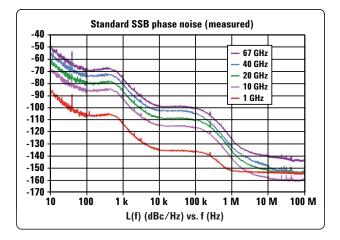
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^{1.} Phase noise specifications are warranted from 15 to 35 °C.

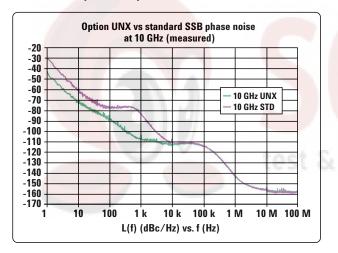
^{2.} Measured at +10 dBm or maximum specified power, whichever is less.

Measured phase noise with E5500 and plotted without spurs

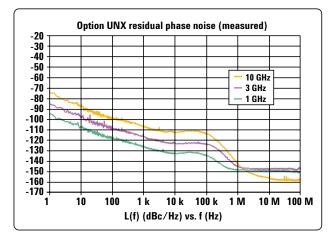
Standard phase noise



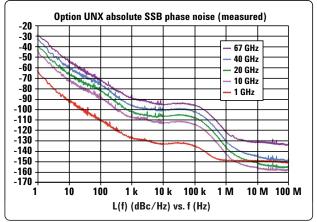
Standard vs. Option UNX phase noise

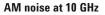


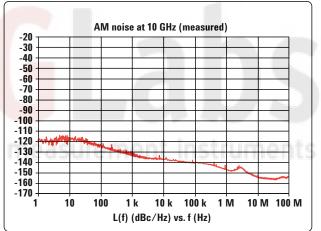
Standard vs. Option UNX phase noise



Option UNX phase noise







Residual FM				
	15 kHz bandwidth)			
CW mode		< N x 6 Hz (typ)		
Option UNX/U		< N x 4 Hz (typ)		
Ramp sweep m	node	< N x 1 kHz (typ)		
Broadband noi	se	(CW mode at +10 dBm	n or maximum specifi	ed out
		power, whichever is l	lower, for offsets >	10 M
> 2.4 to 20 GHz	2	<		
> 20 to 40 GHz		<		
> 40 GHz		< –135 dBc/Hz (typ)		
Measured RM	S jitter ¹			
Standard				
Carrier	SONET/SDH	RMS jitter	Unit intervals	Tin
frequency	data rates	bandwidth	(µUI)	(fs
155 MHz	155 MB/s	100 Hz to 1.5 MHz	25	158
622 MHz	622 MB/s	1 kHz to 5 MHz	21	34
2.488 GHz	2488 MB/s	5 kHz to 20 MHz	57	23
9.953 GHz	9953 MB/s	10 kHz to 80 MHz	152	15
39.812 GHz	39812 MB/s	40 kHz to 320 MHz	627	16
Option UNX				
Carrier	SONET/SDH	RMS jitter	Unit intervals	Tin
frequency	data rates	bandwidth	(µUI)	(fs
155 MHz	155 MB/s	100 Hz to 1.5 MHz	23	151
622 MHz	622 MB/s	1 kHz to 5 MHz	19	30
2.488 GHz	2 <mark>488 M</mark> B/s	5 kHz to 20 MHz	56	22
9.953 GHz	9953 MB/s	10 kHz to 80 MHz	152	15
39.812 GHz	39812 MB/s	40 kHz to 320 MHz	626	16

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Frequency modulation¹ (Option UNT)

Maximum deviation ²	Frequency	Maximum deviation	
	250 kHz to 250 MHz	2 MHz	
	> 250 to 500 MHz	1 MHz	
	> 500 MHz to 1 GHz	2 MHz	
	> 1 GHz to 2 GHz	4 MHz	
	> 2 GHz to 3.2 GHz	8 MHz	
	> 3.2 GHz to 10 GHz	16 MHz	
	> 10 GHz to 20 GHz	32 MHz	
	> 20 GHz to 40 GHz	64 MHz	
	> 40 GHz to 67 GHz	128 MHz	
Resolution	0.1% of deviation or 1 Hz,	whichever is greater	
Deviation accuracy	< ± 3.5% of FM deviation	+ 20 Hz	
	(1 kHz rate, deviations <	N x 800 kHz)	
Modulation frequency resp	conse ³ (at 100 kHz deviation)		
Path [coupling]	1 dB bandwidth	3 dB bandwidth (typ)	
FM path 1 [DC]	DC to 100 kHz	DC to 10 MHz	
FM path 2 [DC]	DC to 100 kHz	DC to 1 MHz	
FM path 1 [AC]	20 Hz to 100 kHz	5 Hz to 10 MHz	
FM path 2 [AC]	20 Hz to 100 kHz	5 Hz to 1 MHz	
DC FM ⁴ carrier offset	±0.1% of set deviation +	(N x 8 Hz)	
Distortion		< 1% (1 kHz rate, deviations < N x 800 kHz)	
Sensitivity	±1 V _{peak} for indicated dev	±1 V _{peak} for indicated deviation	
Paths	FM1 and FM2 are summed internally for composite		
	modulation. Either path may be switched to any one of		
	the modulation sources: Ext1, Ext2, internal1, internal2.		
	The FM2 path is limited to	o a maximum rate of 1 MHz.	
	The FM2 path must be se	t to a deviation less than FM1.	

Phase modulation ⁵ (Option UNT)

Maximum deviation ⁶	Frequency	Normal BW mode	High BW mode
	250 kHz to 250 MHz	20 rad	2 rad
	> 250 to 500 MHz	10 rad	1 rad
	> 500 MHz to 1 GHz	20 rad	2 rad
	> 1 GHz to 2 GHz	40 rad	4 rad
	> 2 GHz to 3.2 GHz	80 rad	8 rad
	> 3.2 GHz to 10 GHz	160 rad	16 rad
	> 10 GHz to 20 GHz	320 rad	32 rad
	> 20 GHz to 40 GHz	640 rad	64 rad
	> 40 GHz to 67 GHz	1280 rad	128 rad
Resolution	0.1% of set deviation		
Deviation accuracy	< ±5% of devia	ation + 0.01 radians (1 k	Hz rate, normal
	BW mode)		
Modulation frequency	response ⁷		
	Normal BW m	ode High B	SW mode
Rates (3 dB BW)	DC to 100 kHz DC to 1 MHz (typ) ⁸		
Distortion	< 1 % (1 kHz r	ate, Total Harmonic Dis	tortion (THD),
	dev < N x 80 r	ad, normal BW mode)	
Sensitivity	±1 V _{peak} for indicated deviation		
Paths	Φ M1 and Φ M2 are summed internally for composite		
	modulation. Either path may be switched to any one of		
	the modulation sources: Ext1, Ext2, internal1, internal2.		
	The Φ M2 path	must be set to a deviat	ion less than $\Phi M1$.

1. Above 50 GHz, FM is useable; however performance is not warranted.

- 2. Through any combination of path1, path2, or path1 + path2.
- 3. Specifications apply in CW and list/step sweep modes. During ramp sweep operation (Option 007), 3 dB bandwidth is typically 50 kHz to 10 MHz (FM1 path), and 50 kHz to 1 MHz (FM2 path).
- 4. At the calibrated deviation and carrier frequency, within 5 °C of ambient temperature at time of user calibration.
- 5. Above 50 GHz, phase modulation is useable; however performance is not warranted.
- 6. Through any combination of path1, path2, or path1 + path2.
- 7. Specifications apply in CW and list/step sweep modes. During ramp sweep operation (Option 007), 3 dB bandwidth is typically 50 kHz to 1 MHz (high BW mode).
- 8. Path 1 is useable to 4 MHz for external inputs less than 0.3 V peak.

Amplitude modulation ¹ (part of Option UNT) (typical)

Depth	Linear mode	Exponential (log) mode (downward modulation only)	
Maximum:			
	ALC On:	> 90%	> 20 dB
ALC Off w	vith Power Search ²		
or ALC (On with Deep AM ³ :	> 95 %	> 40 dB
Settable:		0 to 100 %	0 to 40 dB
		(0 to 100 %/volt sensitivity)	(0 to 40 dB/volt sensitivity)
Resolution:		0.1%	0.01 dB
Accuracy (A	ALC On, 1kHz rate):	$< \pm (6\% \text{ of setting} + 1\%)$	$< \pm$ (2% of setting +0.2dB)
Ext sensitivity		± 1 V _{peak} for indicated depth	-1 V for indicated depth
Rates (3 dB	bandwidth, 30% de	pth)	
DC Coupled		0 to 100 kHz	
AC coupled		10 Hz to 100 kHz (useable to	1 MHz)
Distortion (1 kHz rate, ALC On,	inear mode, Total Harmonic Di	istortion)
30% AM		< 1.5%	
60% AM		< 2%	
Paths		AM1 and AM2 are summed i	internally for composite
		modulation. Either path may be switched to any one of the modulation sources: Ext1. Ext2. Internal1. Internal	





^{1.} AM specifications are typical. For carrier frequencies below 2 MHz or above 50 GHz, AM is useable but not specified. Unless otherwise stated, specifications apply with ALC on and envelope peaks within ALC operating range (-20 dBm to maximum specified power, excluding step-attenuator setting).

^{2.} ALC Off is used for narrow pulse modulation and/or high AM depths, with envelope peaks below ALC operating range. Carrier power level will be accurate after a Power Search is executed.

^{3.} ALC On with Deep AM provides high AM depths together with closed-loop internal leveling. This mode can be used with a repetitive AM waveform (frequency > 10 Hz) with peaks > -5 dBm (nominal, excluding step-attenuator setting).

External modulation inputs (Ext1 & Ext2)

(Option UNT)

Internal modulation source (Option UNT)

Modulation types	AM, FM, and Φ M	
Input impedance	50 or 600 Ω (nom) switched	
High/low indicator		
(100 Hz to 10 MHz BW,	Activated when input level error exceeds 3% (nom)	
ac coupled inputs only)		
Dual function generators provide	s two independent signals (internal1 and internal2) for	
use with AM, FM, ΦM, or LF Out	t.	
Waveforms	Sine, square, positive ramp, negative ramp, triangle,	
	Gaussian noise, uniform noise, swept sine, dual sine ¹	
Rate range	· · · ·	
Sine	0.5 Hz to 1 MHz	
Square, ramp, triangle	0.5 Hz to 100 kHz	
Resolution	0.5 Hz	
Accuracy	Same as timebase	
LF Out		
Output	Internal1 or internal2. Also provides monitoring of	
	internal1or internal2 when used for AM, FM, or Φ M.	
Amplitude	0 to 3 V _{peak} , (nom) into 50 Ω	
Output impedance	50 Ω (nom)	
Swept sine mode: (frequency, ph	nase continuous)	
Operating modes	Triggered or continuous sweeps	
Frequency range	1 Hz to 1 MHz	
Sweep rate	0.5 Hz to 100 kHz sweeps/s, equivalent to sweep times	
	10 us to 2 s	
Resolution	0.5 Hz (0.5 sweep/s)	



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1. Internal2 is not available when using swept sine or dual sine modes.

Pulse modulation^{1, 2} (Option UNU)

500 MHz to 3.2 GHz	Above 3.2 GHz
80 dB (typ)	80 dB
100 ns (typ)	6 ns (typ)
2 us	1 us
0.5 us	0.15 us
10 Hz to 250 kHz	10 Hz to 500 kHz
dc to 1 MHz	dc to 3 MHz
±0.5 dB	±0.5 dB
±0.5 dB (typ)	±0.5 dB (typ)
±50 ns (typ)	±5 ns (typ)
< 200 mv (typ)	< 2 mv (typ)
50 ns (nom)	50 ns (nom)
270 ns (nom)	35 ns (nom)
< 10% (typ)	< 10% (typ)
+1 V _{peak} = RF On	+1 V _{peak} = RF On
50 Ω (nom)	50 Ω (nom)
	80 dB (typ) 100 ns (typ) 2 us 0.5 us 10 Hz to 250 kHz dc to 1 MHz ±0.5 dB ±0.5 dB (typ) ±50 ns (typ) < 200 mv (typ) 50 ns (nom) 270 ns (nom) < 10% (typ) +1 V _{peak} = RF On

Narrow pulse modulation^{1, 2} (Option UNW)

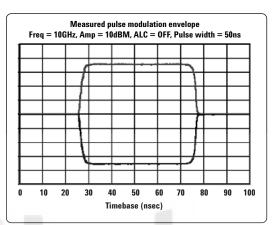
	10 MHz to 3.2 GHz	Above 3.2 GHz
On/Of <mark>f ra</mark> tio	80 dB	80 dB
Rise/Fall times (Tr, Tf)	10 ns (8 ns typical)	10 ns (6 ns typical)
Minimum pulse width		
Internally leveled	1 us	1 us
Level hold (AL <mark>C off</mark> w <mark>ith p</mark> ower <mark>sea</mark> rch)	20 ns	20 ns
Repetition frequency		
Internally leveled	10 Hz to 500 kHz	10 Hz to 500 kHz
Level hold (ALC off with power search)	dc to 5 MHz	dc to 10 MHz
Level accuracy (relative to CW)	irement i	nstrument
Internally leveled	±0.5 dB	±0.5 dB (0.15 dB typical)
Level hold (ALC off with power search)	±1.3 dB (typ)	±0.5 dB (typ)

 With ALC off, specs apply after the execution of power search. Specifications apply with Atten Hold Off (default mode for instruments with attenuator), or ALC level between -5 and +10 dBm or maximum specific power, whichever is lower. Above 50 GHz, pulse modulation is useable; however performance is not warranted.

^{2.} Power search is a calibration routine that improves level accuracy with ALC off. The instrument microprocessor momentarily closes the ALC loop to find the modulator drive setting necessary to make the quiescent RF level equal to an entered value, then opens the ALC loop while maintaining that modulator drive setting. When executing power search, RF power will be present for typically 10 to 50 ms; the step attenuator (Option 1E1) can be set to automatically switch to maximum attenuation to protect sensitive devices. Power search can be configured to operate either automatically or manually at the carrier frequency, or over a user-definable frequency range.

^{3.} With attenuator in 0 dB position. Video feed-through decreases with attenuator setting.

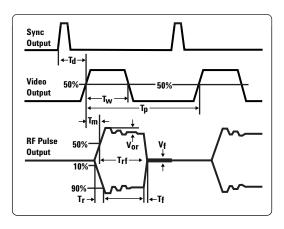
	10 MHz to 3.2 GHz	Above 3.2 GHz
Width compression	±5 ns (typ)	±5 ns (typ)
(RF width relative to video out)		
Video feed-through ¹	< 125 mv (typ)	< 2 mv (typ)
Video delay (ext input to video)	50 ns (nom)	50 ns (nom)
RF delay (video to RF output)	45 ns (nom)	35 ns (nom)
Pulse overshoot	< 15% (typ)	< 10% (typ)
Input level	+1 V _{peak} = RF On	+1 V _{peak} = RF On
Input impedance	50 Ω (nom)	50 Ω (nom)



Internal pulse generator (Option UNU or UNW)

Modes	Free-run, triggered, triggered with delay,
incuce	doublet, and gated. Triggered with delay,
	doublet, and gated require external
	trigger source.
Period (PRI) (Tp)	70 ns to 42 s
	(Repetition frequency: 0.024 Hz to
	14.28 MHz)
Pulse width (Tw)	10 ns to 42 s
Delay (Td)	ement instruments
Free-run mode	0 to ±42 s
Triggered with delay and doublet modes	75 ns to 42s with ±10 ns jitter
Resolution	10 ns (width, delay, and PRI)

Td Video delay (variable) Tw Video pulse width (variable) Tp Pulse period (variable) Tm RF delay Trf RF pulse width Tf RF pulse fall time Tr RF pulse rise time Vor Pulse overshoot Vf Video feedthrough



Simultaneous modulation

All modulation types (FM, AM, Φ M, and pulse modulations) may be simultaneously enabled except: FM with Φ M, and linear AM with exponential AM. AM, FM, and Φ M can sum simultaneous inputs from any two sources (Ext1, Ext2, internal1, or internal2). Any given source (Ext1, Ext2, internal1, or internal2) may be routed to only one activated modulation type.

1. With attenuator in 0 dB position. Video feed-through decreases with attenuator setting.

Remote programming

Interfaces	GPIB (IEEE-488.2,1987) with listen and talk, RS-232, and 10BaseT LAN interface.
Control languages	SCPI version 1997.0. Completely code compatible with previous PSG signal generator models: • E8241A • E8244A • E8251A • E8254A • E8247C • E8257C
	The E8257D will emulate the applicable commands for the following Agilent signal generators, providing general compatibility with ATE systems: • 8340-series (8340/41B) • 8360-series (836xxB/L) • 83700-series (837xxB) • 8662A/63A
IEEE-488 functions	SH1, AH1, T6, TE0, L4, LE0, SR1, RL1, PP0, DC1, DT0, C0, E2.
ISO compliant	This family of signal generators is manufactured in an ISO-9001 registered facility in concurrence with Agilent commitment to quality.
Agilent IO Libraries	Agilent's IO Library Suite ships with the E8257D to help you quickly establish an error-free connection between your PC and instruments – regardless of the vendor. It provides robust instrument control and works with the software development environment you choose.



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General specifications

Power requirements	90 to 132 VAC 47 to 64 Hz or 365 to 435 Hz; or
	195 to 267 VAC 47 to 64 Hz, (automatically selected)
	< 250 W typical, 300 W maximum.
Operating temperature range	0 to 55 °C
Storage temperature range ¹	-40 to 70 °C
Optimal altitude	< 4,572 m (15,000 ft.)
Shock and vibration	
Operating random vibration ²	5 to 500 Hz, 0.21 g rms
Survival swept sine vibration	5 to 500 Hz, 0.5 g
Survival random vibration	5 to 500 Hz, 2.09 g rms
Functional shock (half-sine, 30 g, 11 ms)	Meets the requirements of MIL-PRF-28800F for
and bench drop test	class 3 equipment.
EMC	Meets the conducted and radiated interference and immunity requirements of IEC/EN 61326-1. Meets radiated emission requirements of CISPR Pub 11/1997 Group 1 class A.
Storage registers	Memory is shared by instrument states and sweep list files. There is 14 MB of flash memory available in the E8257D PSG. Depending on how the memory is used, a maximum of 1000 instrument states can be saved.
Security	Display blanking Memory clearing functions (see Application Note <i>Security of Agilent Signal</i> <i>Generators Issues and Solutions</i> , literature number 5989-1091EN)
Compatibility	Agilent 83550 Series Millimeter Heads and OML millimeter source modules. Agilent 8757D scalar network analyzers. Agilent EPM Series power meters.
self-test & measu	Internal diagnostic routine tests most modules (including microcircuits) in a preset condition. For each module, if its node voltages are within
	acceptable limits, then the module "passes" the test.
Weight	< 22 kg (48 lb.) net, < 30 kg (68 lb.) shipping
vveignt	170 II 400 M/ E1E D
Dimensions	178 mm H x 426 mm W x 515 mm D (7″ H x 16.8″ W x 20.3″ D in.)



2. As is the case with all signal generation equipment, phase noise specifications are not warranted in a vibrating environment.

^{1.} Storage below –20 $^{\circ}\mathrm{C}$ instrument states may be lost.

Input/Output Descriptions

Front panel connectors	RF output	Output impedance 50 Ω (nom)
-	-	
(All connectors are BNC female	Option 520 Options 522 540 and 550	Precision APC-3.5 male, or Type-N with Option 1ED
unless otherwise noted.) ¹	Options 532, 540 and 550	Precision 2.4 mm male; plus 2.4 – 2.4 mm and
	0	2.4 – 2.9 mm female adapters
	Option 567	Precision 1.85 mm male; plus 1.85 – 1.85 mm and
		2.4 – 2.9 mm female adapters
	ALC input	Used for negative external detector leveling. Nominal input impedance 120 k Ω , damage level ±15 V.
	LF output	Outputs the internally generated LF source. Nominal
		outputs the internally generated Li source. Nonlinal output impedance 50 Ω .
	External input 1	Drives either AM, FM, or Φ M. Nominal input impedance
		50 or 600 Ω , damage levels are 5 V _{rms} and 10 V _{peak} .
	External input 2	Drives either AM, FM, or Φ M. Nominal input impedance
	External input 2	
	Pulse/trigger gate input	50 or 600 Ω, damage levels are 5 V_{rms} and 10 V_{peak} . Accepts input signal for external fast pulse modulation.
	Fuise/ ungger gate input	Also accepts external trigger pulse input for internal
		pulse modulation. Nominal impedance 50 Ω . Damage
		levels are 5 V_{rms} and 10 V_{peak} .
	Pulse video out	Outputs a signal that follows the RF output in all pulse
		modes. TTL-level compatible, nominal source
		impedance 50 Ω .
	Pulse sync out	Outputs a synchronizing pulse, nominally 50 ns width,
		during internal and triggered pulse modulation.
		TTL-level compatible, nominal source impedance 50 Ω .
Beer neuel connectors		
Rear panel connectors	Auxiliary interface (dual mode)	Used for RS-232 serial communication and for
(all connectors are BNC female		master/slave source synchronization.
unles <mark>s otherw</mark> ise noted.) ¹		(9-pin subminiature female connector).
	GPIB LAN	Allows communication with compatible devices
		Allows 10BaseT LAN communication
	10 MHz input	Accepts an external reference (timebase) input (at 1,
		2, 2.5, 5, 10 MHz for standard and 10 MHz only for Option UNX and UNR)
		Nominal input impedance 50 Ω
		Damage levels $> +10$ dBm
	10 MHz output	Outputs internal or external reference signal. Nominal
		output impedance 50 Ω . Nominal output power +8 dBm.
	Sweep output (dual mode)	Supplies a voltage proportional to the RF power or
	erroop output (daar mode)	frequency sweep ranging form 0 volts at the start of
		sweep to ± 10 volts (nom) at the end of sweep,
		regardless of sweep width.
		0
		During CW operation, supplies a voltage proportional
		to the output frequency, +10 volts (nom) corresponding
		to the maximum specified frequency.
		When connected to an Agilent 8757D scalar network
		analyzer (Option 007), generates a selectable number
		of equally spaced 1 us pulses (nom) across a ramp
		(analog) sweep. Number of pulses can be set form
		101 to 1601 by remote control from the 8757D.
		Output impedance: < 1 Ω (nom), can drive 2000 Ω .

1. Digital inputs and output are 3.3 V CMOS unless indicated otherwise. Inputs will accept 5 V CMOS, 3 V CMOS, or TTL voltage levels.

Stop sweep In/Out	Open-collector, TTL-compatible input/output. In ram
	sweep operation, provides low level (nominally 0 V)
	during sweep retrace and bandcross intervals, and
	high level during the forward portion of the sweep.
	Sweep will stop when grounded externally, sweep
	will resume when allowed to go high.
Trigger output (dual mode)	Outputs a TTL signal. High at start of dwell, or when waiting for point trigger; low when dwell is over or
	point trigger is received. In ramp sweep mode, provide
	1601 equally-spaced 1us pulses (nom) across a
	ramp sweep. When using LF Out, provides 2 us puls
	at start of LF sweep.
Trigger input	Accepts TTL signal for triggering point-to-point in
	manual sweep mode, or to trigger start of LF sweep.
	Damage levels \geq +10 V or \leq -4 V.
Source module interface	Provides power and leveling connections to the
	millimeter source modules.
Source settled	Provides an output trigger that indicates when the
	signal generator has settled to a new frequency or
	power level. High indicates source not settled, Low
	indicates source settled.
Z-axis Blank/Markers	During ramp sweep, supplies +5 V (nom) level
	during retrace and bandswitch intervals.
	Supplies –5 V (nom) level when the RF frequency
	is at a marker frequency.
10 MHz EFC	(Option UNR/UNX only) Accepts an external DC
	voltage, ranging from –5 V to +5 V, for electronic
	frequency control (EFC) of the internal 10 MHz
	reference oscillator. This voltage inversely tunes the
	oscillator about its center frequency approximately
	-0.07 ppm/V. The nominal input impedance is
	greater than 1 M Ω .



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Options, Accessories, and Related Products

Model/option	Description	
E8257D-520	Frequency range from 250 kHz to 20 GHz	
E8257D-532	Frequency range from 250 kHz to 31.8 GHz	
E8257D-540	Frequency range from 250 kHz to 40 GHz	
E8257D-550	Frequency range from 250 kHz to 50 GHz	
E8257D-567	Frequency range from 250 kHz to 67 GHz	
E8257D-007	Analog ramp sweep	
E8257D-UNX	Ultra low phase noise	
E8257D-UNT	AM, FM, phase modulation, and LF output	
E8257D-UNU	Pulse modulation	
E8257D-UNW ¹	Narrow pulse modulation	
E8257D-1EA	High output power	
E8257D-1E1	Step attenuator	
E8257D-1ED	Type-N (f) RF output connector (Option 520 only)	
E8257D-1EH	Improved harmonics below 2 GHz	
E8257D-1EM	Moves all front panel connectors to the rear panel	
E8257D-1EZ	Extended support life	
E8257D-1CN	Front handle kit	
E8257D-1CM	Rackmount flange kit	
E8257D-1CP	Rackmount flange and front handle kit	
E8257D-C09	Move all front panel connectors to the rear panel except for the RF	
	output connector	
E8257D-HSM ²	S <mark>can modula</mark> tion (20 GHz model only)	
E8257 <mark>D-H</mark> 1S	1 GHz external frequency reference input and output	
E8257D-HCC	Connections for phase coherency > 250 MHz	
E8257D-HIG	Connec <mark>tions f</mark> or phase coherency and improved phase stability	
	< 250 MHz	
E8257D-H30 ¹	Internal mixer for up conversion capability in the 20, 31.8, and	
	40 GHz models	
E8257D-H60 ¹	Internal mixer for up conversion capability in the 50 and 67 GHz models	
E8257D-UK6	Commercial calibration certificate and test data	
E8257D-CD1	CD-ROM containing the English documentation set	
E8257D-ABA	Printed copy of the English documentation set	
E8257D-0BW 8120-8806	Printed copy of the assembly-level service guide Master/slave interface cable	
9211-2656 9211-7481 E8257DS15 ³ E8257DS12 ³ E8257DS10 ³ E8257DS08 ³ E8257DS06 ³ E8257DS05 ³ E8257DS03 ³	Transit case Transit case Transit case with wheels OML Inc. Millimeter source module, 50 GHz to 75 GHz at +8 dBm OML Inc. Millimeter source module, 60 GHz to 90 GHz at +6 dBm OML Inc. Millimeter source module, 75 GHz to 110 GHz at +5 dBm OML Inc. Millimeter source module, 90 GHz to 140 GHz at -2 dBm OML Inc. Millimeter source module, 110 GHz to 170 GHz at -6 dBm OML Inc. Millimeter source module, 140 GHz to 220 GHz at -12 dBm OML Inc. Millimeter source module, 220 GHz to 325 GHz at -25 dBm	

Must be ordered with Option 1E1.
 Must be ordered with Option UNT and not available with Option UNU.

^{3.} Millimeter source module a product of Oleson Microwave Labs, Inc. and must be ordered with Option 1EA.

Web Resources

For additional information, visit: www.agilent.com/find/psg

For more information about renting, leasing or financing Agilent's latest technology, visit: www.agilent.com/find/buy/alternatives

For more accessory information, visit: www.agilent.com/find/accessories

For additional description of Agilent's IO Libraries Suite features and installation requirements, please go to: www.agilent.com/find/iosuite/database

Related Agilent Literature



Agilent PSG Signal Generators Brochure, Literature number 5989-1324EN

E8257D PSG Signal Generators Configuration Guide, Literature number 5989-1325EN

E8267D PSG Vector Signal Generator Data Sheet, Literature number 5989-0697EN

E8267<mark>D</mark> PSG Vector Signal Gener</mark>ator Config<mark>urat</mark>ion Guide, Literature number 5989-1326EN

Millimeter Wave Source Modules from OML, Inc. for the Agilent PSG Signal Generators Technical Overview, Literature number 5989-2923EN

Security of Agilent Signal Generators Issues and Solutions, Literature number 5989-1091EN



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